

Lists of atomic coordinates, displacement parameters, structure factors and complete geometry have been deposited with the IUCr (Reference: SK1062). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

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## Bis(*p*-methoxyphenyl) Telluride

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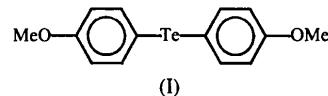
## Abstract

The title compound, C<sub>14</sub>H<sub>14</sub>O<sub>2</sub>Te, displays an angular geometry at tellurium, with a C—Te—C angle of 99.5(1) $^{\circ}$  and Te—C distances of 2.110(3) and 2.112(3) Å. The Te atom is displaced by 0.1963(3) and 0.0044(3) Å out of the planes of the aromatic rings. These rings are approximately perpendicular to one another [dihedral angle 70.4(1) $^{\circ}$ ], while each methoxy group is almost coplanar with the phenyl ring to which it is bonded [dihedral angles 3.3(2) and 1.5(3) $^{\circ}$ ].

## Comment

Aside from the pioneering work of Blackmore & Abrahams (1955) on (*p*-MeC<sub>6</sub>H<sub>4</sub>)<sub>2</sub>Te, based on a partial data set, only three other diaryl tellurides, Ar—Te—Ar', have been structurally characterized, *viz.* (*p*-EtOC<sub>6</sub>H<sub>4</sub>)Te[*o*-C<sub>6</sub>H<sub>4</sub>(*o*-C<sub>5</sub>NH<sub>4</sub>)] (Al-Salim, West & McWhinnie, 1988), [*o*-(*p*-MeOC<sub>6</sub>H<sub>4</sub>N:CH)C<sub>6</sub>H<sub>4</sub>]<sub>2</sub>Te (Sadekov *et al.*, 1989) and (*o*-PhC<sub>6</sub>H<sub>4</sub>)<sub>2</sub>Te (Chen, Hamor, Singh & McWhin-

nie, 1996). As part of our synthetic and structural studies on organotellurium compounds (Farran, Alvarez-Larena, Piniella, Germain & Torres-Castellanos, 1995a,b; Matheus, Torres, Piniella, Briansó & Miravitles, 1991; Matheus, Torres, Cabiativa, Fuertes & Miravitles, 1991; Matheus, Torres, Piniella & Miravitles, 1991; Torres, 1990), we report here the structure of bis(*p*-methoxyphenyl) telluride, (I).



The crystals of (I) contain discrete (*p*-MeOC<sub>6</sub>H<sub>4</sub>)<sub>2</sub>Te molecules (Fig. 1) which display an angular geometry at tellurium, as predicted by the valence-shell electron-pair repulsion (VSEPR) model for an AX<sub>2</sub>E<sub>2</sub> molecule (Gillespie & Hargittai, 1991, and references therein). The Te—C distances are equal within experimental error and their values are comparable with that of 2.116(20) Å tabulated by Allen *et al.* (1987) for Te—C(aryl) bonds, and with those of 2.105(5) and 2.125(5) Å observed in (*o*-PhC<sub>6</sub>H<sub>4</sub>)<sub>2</sub>Te (Chen *et al.*, 1996). As expected, the C—Te—C angle is substantially smaller than the tetrahedral value (109.5 $^{\circ}$ ) due to the repulsion of bonded electron pairs by lone pairs. This angle, however, is somewhat larger than those observed in the above-mentioned diaryl tellurides; 94.8(2) in (*p*-EtOC<sub>6</sub>H<sub>4</sub>)Te[*o*-C<sub>6</sub>H<sub>4</sub>(*o*-C<sub>5</sub>NH<sub>4</sub>)] (Al-Salim *et al.*, 1988), 96.3(2) in [*o*-(*p*-MeOC<sub>6</sub>H<sub>4</sub>N:CH)C<sub>6</sub>H<sub>4</sub>]<sub>2</sub>Te (Sadekov *et al.*, 1989) and 96.2(2) $^{\circ}$  in (*o*-PhC<sub>6</sub>H<sub>4</sub>)<sub>2</sub>Te (Chen *et al.*, 1996).

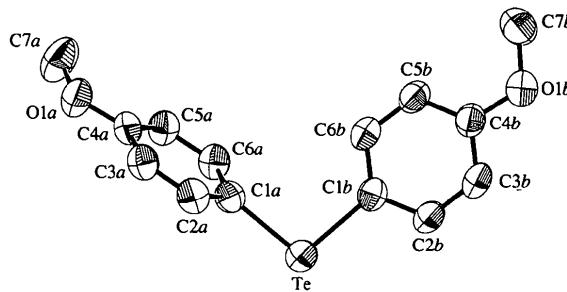


Fig. 1. The molecular structure of the title compound showing the displacement ellipsoids drawn at the 50% probability level. H atoms have been omitted for clarity.

Each aromatic ring is planar [to within 0.007(3) Å]. The Te atom lies 0.1963(3) and 0.0044(3) Å from the planes of rings *a* and *b*, respectively. The angles between the C—Te—C plane and those of the phenyl rings differ [70.8(1) and 2.0(1) $^{\circ}$  for rings *a* and *b*] and the phenyl rings are approximately perpendicular to one another [inter-ring dihedral angle 70.4(1) $^{\circ}$ ].

The methoxy groups are almost coplanar with their associated phenyl rings [dihedral angles 3.3 (2) and 1.5 (3) $^{\circ}$  for molecules *a* and *b*].

The crystal packing involves only van der Waals interactions.

## Experimental

The title compound was synthesized according to the method of Morgan & Kellett (1926). Crystals suitable for X-ray analysis were obtained by slow evaporation of a dimethylsulfoxide (DMSO) solution.

### Crystal data

$C_{14}H_{14}O_2Te$	Mo $K\alpha$ radiation
$M_r = 341.85$	$\lambda = 0.71069 \text{ \AA}$
Monoclinic	Cell parameters from 25 reflections
$P2_1/n$	$\theta = 11.6\text{--}14.0^{\circ}$
$a = 6.283 (1) \text{ \AA}$	$\mu = 2.190 \text{ mm}^{-1}$
$b = 26.437 (2) \text{ \AA}$	$T = 295 (2) \text{ K}$
$c = 8.1851 (9) \text{ \AA}$	Plate
$\beta = 96.54 (1)^{\circ}$	$0.41 \times 0.33 \times 0.11 \text{ mm}$
$V = 1350.7 (3) \text{ \AA}^3$	Colourless
$Z = 4$	
$D_x = 1.681 \text{ Mg m}^{-3}$	
$D_m$ not measured	

### Data collection

Enraf–Nonius CAD-4 diffractometer	1940 reflections with $I > 2\sigma(I)$
$\omega$ - $2\theta$ scans	$\theta_{\max} = 25^{\circ}$
Absorption correction:	$h = -7 \rightarrow 7$
empirical from $\psi$ scans	$k = 0 \rightarrow 31$
(North, Phillips & Mathews, 1968)	$l = 0 \rightarrow 9$
$T_{\min} = 0.547$ , $T_{\max} = 0.786$	3 standard reflections frequency: 60 min
2373 measured reflections	intensity decay: none
2373 independent reflections	

### Refinement

Refinement on $F^2$	$(\Delta/\sigma)_{\max} = 0.001$
$R(F) = 0.0250$	$\Delta\rho_{\max} = 0.45 \text{ e \AA}^{-3}$
$wR(F^2) = 0.0688$	$\Delta\rho_{\min} = -0.58 \text{ e \AA}^{-3}$
$S = 1.084$	Extinction correction: none
2373 reflections	Scattering factors from <i>International Tables for Crystallography</i> (Vol. C)
156 parameters	
H atoms: see below	
$w = 1/[\sigma^2(F_o^2) + (0.0364P)^2 + 0.472P]$	
where $P = (F_o^2 + 2F_c^2)/3$	

Table 1. Selected geometric parameters ( $\text{\AA}$ ,  $^{\circ}$ )

Te—C1a	2.110 (3)	O1a—C7a	1.425 (5)
Te—C1b	2.112 (3)	C4b—O1b	1.369 (4)
C4a—O1a	1.364 (4)	O1b—C7b	1.398 (5)
C1a—Te—C1b	99.5 (1)	C2b—C1b—Te	117.1 (2)
C6a—C1a—Te	121.6 (2)	C6b—C1b—Te	124.8 (2)
C2a—C1a—Te	119.7 (2)	O1b—C4b—C5b	125.3 (3)
O1a—C4a—C5a	125.1 (3)	O1b—C4b—C3b	115.8 (3)
O1a—C4a—C3a	115.4 (3)	C4b—O1b—C7b	119.0 (3)
C4a—O1a—C7a	118.0 (3)		

The title structure was solved by direct methods. H atoms were placed in calculated positions using a riding model, with fixed C—H distances (0.93  $\text{\AA}$  for  $C_{sp^2}$ , 0.96  $\text{\AA}$  for  $C_{sp^3}$ ) and  $U_{\text{iso}} = pU_{\text{eq}}(\text{parent atom})$  (where  $p = 1.2$  for  $C_{sp^2}$  and 1.5 for  $C_{sp^3}$ ). A single orientation parameter was refined for each methyl group. Geometrical calculations were carried out using the PARST95 program (Nardelli, 1995).

Data collection: CAD-4 Software (Enraf–Nonius, 1989). Cell refinement: CAD-4 Software. Program(s) used to solve structure: SHELXS86 (Sheldrick, 1990). Program(s) used to refine structure: SHELXL93 (Sheldrick, 1993). Molecular graphics: ZORTEP (Zsolnai & Pritzkow, 1994). Software used to prepare material for publication: SHELXL93.

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